Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/633,782	LEE ET AL.	
Examiner	Art Unit	
HOAN C NGUYEN	2871	

	SEAR	CHED	
Class	Subclass	Date	Examiner
349	update	7/14/2006	CHN
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East search in US-PGPUB, USPAT, EPO, JPO, Derwent and IBM_TDB	7/14/2006	CHN